

Notice of References Cited	Application/Control No. 10/026,618	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Emmanuel Bayard	Art Unit 2611	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,079,604	07-2006	Miller et al.	375/343
*	B	US-5,805,017	09-1998	Razzell, Charles J.H.	329/300
*	C	US-2002/0090923	07-2002	Muramoto, Kimio	455/192.2
*	D	US-6,567,480	05-2003	Brardjanian et al.	375/331
*	E	US-6,925,108	08-2005	Miller et al.	375/150
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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